

BFY 64

HIGH CURRENT GENERAL PURPOSE TYPE

PNP DIFFUSED SILICON PLANAR EPITAXIAL TRANSISTOR

GENERAL DESCRIPTION—The BFY64 is a PNP silicon PLANAR epitaxial transistor designed for digital and analog applications at current levels up to 500 milliamperes. Its high beta, high f_T at high current, high V_{CE0} , and low noise figure make it ideal for use in line driver, memory applications, and in low-noise amplifiers.

ABSOLUTE MAXIMUM RATINGS (Note 1)

Maximum Temperatures

Storage Temperature

-65°C to +200°C

Operating Junction Temperature

200°C Maximum

Maximum Power Dissipations

Total Dissipation at 25°C Case Temperature (Notes 2 and 3)

3.0 Watts

at 25°C Ambient Temperature (Notes 2 and 3)

0.7 Watt

Maximum Voltages

V_{CBO} Collector to Base Voltage

-40 Volts

V_{CEO} Collector to Emitter Voltage (Note 4)

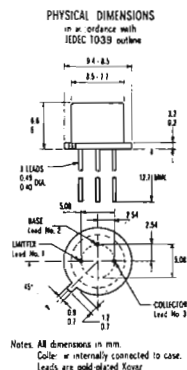
-40 Volts

V_{EBO} Emitter to Base Voltage

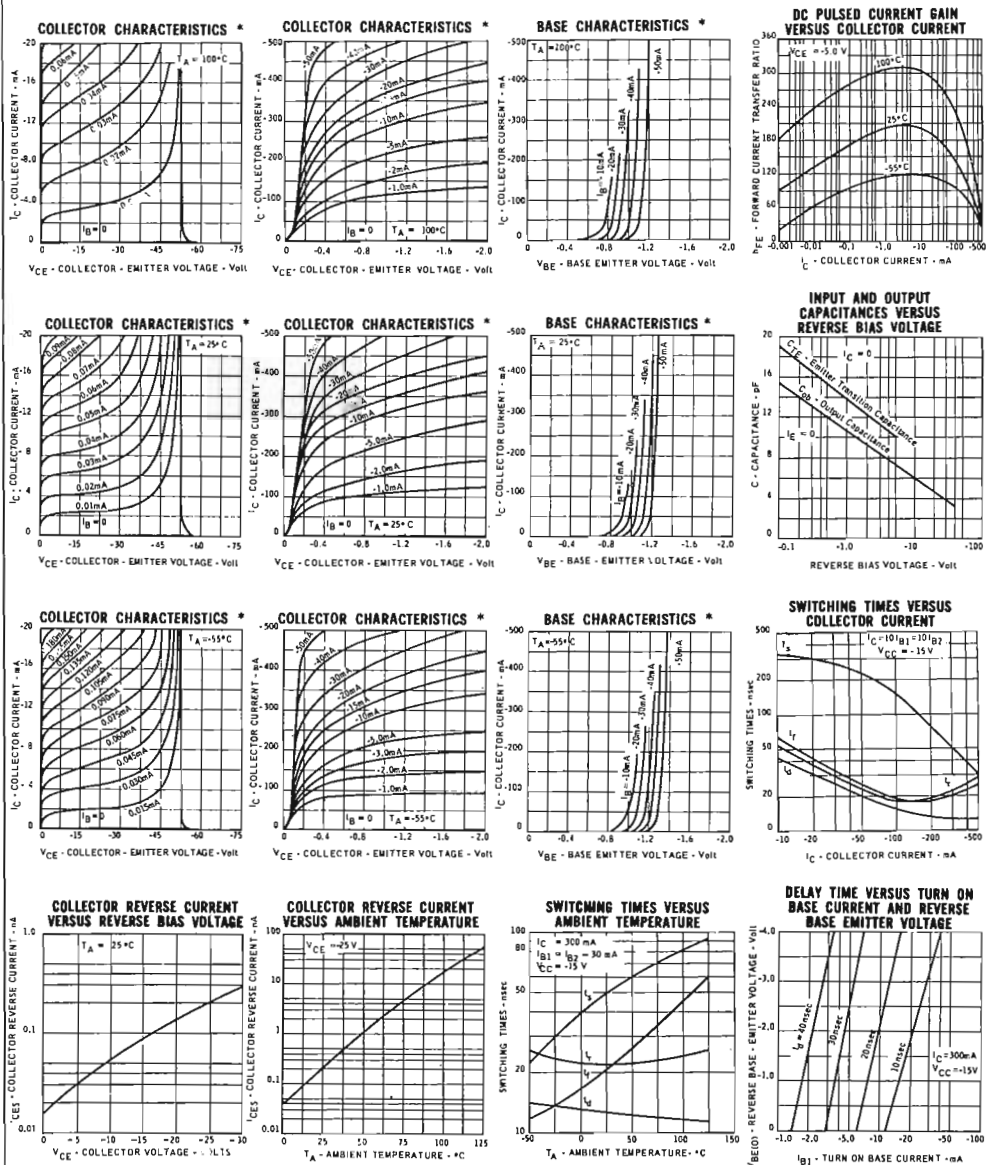
-5.0 Volts

ELECTRICAL CHARACTERISTICS (25°C free air temperature unless otherwise noted)

SYMBOL	CHARACTERISTIC	MIN.	TYP.	MAX.	UNITS	TEST CONDITIONS
h_{FE}	DC Current Gain		130			$I_C = 10 \mu A$ $V_{CE} = -10 V$
h_{FE}	DC Current Gain		200			$I_C = 1.0 mA$ $V_{CE} = -10 V$
h_{FE}	DC Pulse Current Gain (Note 5)	80	200			$I_C = 10 mA$ $V_{CE} = -10 V$
h_{FE}	DC Pulse Current Gain (Note 5)		150			$I_C = 50 mA$ $V_{CE} = -1.0 V$
h_{FE}	DC Pulse Current Gain (Note 5)		130			$I_C = 150 mA$ $V_{CE} = -10 V$
$V_{BE(sat)}$	Base Saturation Voltage (Note 5)	-0.92	-1.1	V		$I_C = 50 mA$ (pulsed) $I_B = 2.5 mA$
$V_{BE(sat)}$	Base Saturation Voltage (Note 5)	-1.0	-1.4	V		$I_C = 150 mA$ (pulsed) $I_B = 15 mA$
$V_{BE(sat)}$	Base-Emitter Saturation Voltage (Note 5)		-2.2	V		$I_C = 500 mA$ (pulsed) $I_B = 50 mA$
$V_{CE(sat)}$	Collector Saturation Voltage (Note 5)	-0.08	-0.3	V		$I_C = 50 mA$ (pulsed) $I_B = 2.5 mA$
$V_{CE(sat)}$	Collector Saturation Voltage (Note 5)	-0.18	-0.5	V		$I_C = 150 mA$ (pulsed) $I_B = 15 mA$
$V_{CE(sat)}$	Collector Saturation Voltage (Note 5)	-0.6	-1.8	V		$I_C = 500 mA$ (pulsed) $I_B = 50 mA$
I_{CES}	Collector Cutoff Current		0.2	30	nA	$V_{CE} = 25 V$ $V_{BE} = 0$
BV_{CBO}	Collector to Base Breakdown Voltage				V	$I_C = 10 \mu A$ $I_E = 0$
BV_{EBO}	Emitter to Base Breakdown Voltage	-40			V	$I_C = 10 \mu A$ $I_C = 0$
$V_{CEO(max)}$	Collector to Emitter Sustaining Voltage (Notes 4 and 5)	-40			V	$I_C = 10 mA$ (pulsed) $I_B = 0$
h_{fe}	High Frequency Current Gain ($f = 100 Mc/s$)	2.0	2.5			$I_C = 50 mA$ $V_{CE} = -20 V$
C_{ob}	Output Capacitance		6.0	10	pF	$I_E = 0$ $V_{CB} = -10 V$
C_{TE}	Emitter Transition Capacitance		15	25	pF	$I_C = 0$ $V_{EB} = -0.5 V$
NF	Noise Figure (Note 6)		1.0		db	$I_C = 30 \mu A$ $V_{CE} = -5.0 V$
t_{on}	Turn On Time (Note 7)		35	50	nsec	$I_C = 300 mA$ $I_{B1} = 30 mA$
t_{off}	Turn Off Time (Note 7)		70	120	nsec	$I_C = 300 mA$ $I_{B1} = 30 mA$ $I_{B2} = -30 mA$
h_{ie}	Input Resistance ($f = 1 Kc/s$)		1050		Ω	$I_C = 10 mA$ $V_{CE} = -10 V$
h_{oe}	Output Conductance ($f = 1 Kc/s$)		110		μmho	$I_C = 10 mA$ $V_{CE} = -10 V$
h_{re}	Voltage Feedback Ratio ($f = 1 Kc/s$)		240		$\times 10^{-6}$	$I_C = 10 mA$ $V_{CE} = -10 V$
h_{fe}	Small Signal Current Gain ($f = 1 Kc/s$)		200			$I_C = 10 mA$ $V_{CE} = -10 V$



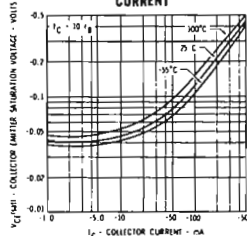
TYPICAL ELECTRICAL CHARACTERISTICS



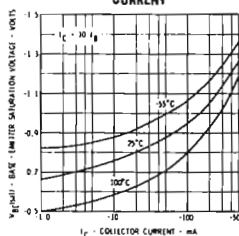
* Single family characteristics on Transistor Curve Tracer.

TYPICAL ELECTRICAL CHARACTERISTICS

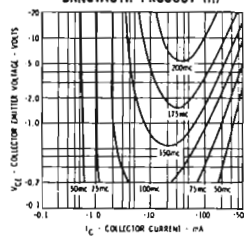
PULSED COLLECTOR SATURATION VOLTAGE VERSUS COLLECTOR CURRENT



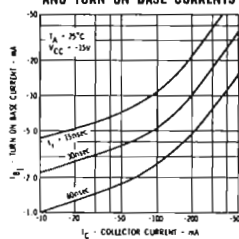
PULSED BASE SATURATION VOLTAGE VERSUS COLLECTOR CURRENT



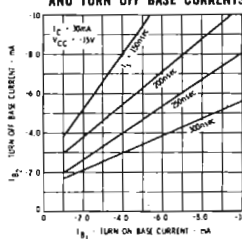
CONTOURS OF CONSTANT GAIN BANDWIDTH PRODUCT (f_T)



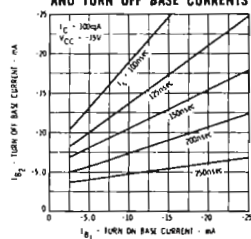
RISE TIME VERSUS TURN ON AND TURN OFF BASE CURRENTS



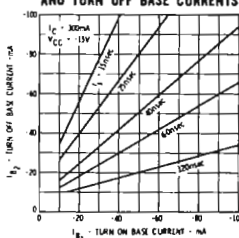
STORAGE TIME VERSUS TURN ON AND TURN OFF BASE CURRENTS



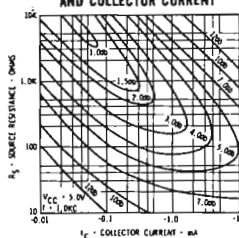
STORAGE TIME VERSUS TURN ON AND TURN OFF BASE CURRENTS



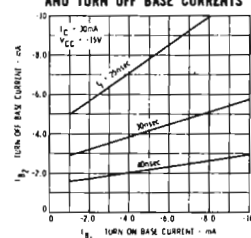
STORAGE TIME VERSUS TURN ON AND TURN OFF BASE CURRENTS



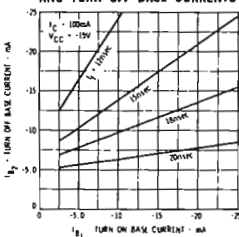
NOISE FIGURE VERSUS SOURCE RESISTANCE AND COLLECTOR CURRENT



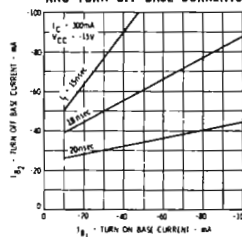
FALL TIME VERSUS TURN ON AND TURN OFF BASE CURRENTS



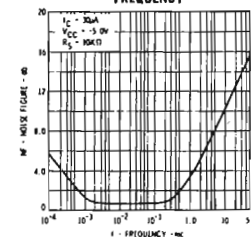
FALL TIME VERSUS TURN ON AND TURN OFF BASE CURRENTS



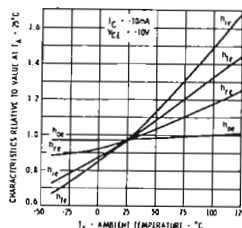
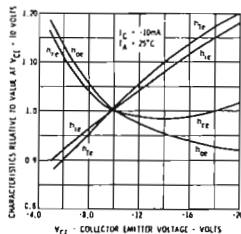
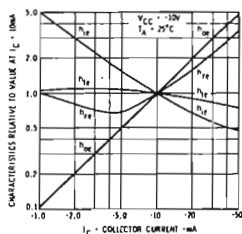
FALL TIME VERSUS TURN ON AND TURN OFF BASE CURRENTS



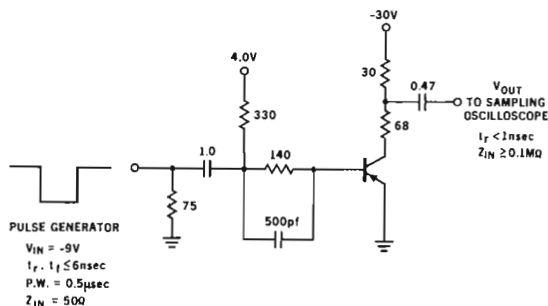
NOISE FIGURE VERSUS FREQUENCY



TYPICAL COMMON EMITTER CHARACTERISTICS



T_{ON} and T_{OFF} TEST CIRCUIT



NOTES:

- (1) These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
- (2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
- (3) These ratings give a maximum junction temperature of 200°C and junction-to-case thermal resistance of 58.3°C/Watt (derating factor of 17.2 mW/°C); junction-to-ambient thermal resistance of 250°C/Watt (derating factor of 4.0 mW/°C).
- (4) This rating refers to a high-current point where collector-to-emitter voltage is lowest. For more information send for SGS Publication AR 5.
- (5) Pulse Conditions: length = 300 μsec; duty cycle = 1%.
- (6) $f = 1.0$ Kc/s; $R_S = 10$ KΩ.
- (7) See switching circuit for exact values of I_C , I_{B1} , and I_{B2} .